Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/801,154	AHN ET AL.
Examiner	Art Unit
XIAO M. WU	2674

CEARCUED					
SEARCHED					
Class	Subclass	Date	Examiner		
345	173-177	3/17/2006	x.w.		
178	18.01 18.1	3/17/2006	X.W.		
178	18.03	3/17/2006	X.W.		
349	58,61 96	3/17/2006	X.W.		
349	158	3/17/2006	X.W.		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
east and inventors search	3/17/2006	x.w.	